

Notice of References Cited

Application/Control No.

10/780,211

Applicant(s)/Patent Under
Reexamination
KUTH ET AL.

Examiner

NEAL R. SEREBOFF

Art Unit

3626

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,734,883 A	03-1998	Umen et al.	707/1
*	B	US-6,272,470 B1	08-2001	Teshima, Fumiaki	705/3
*	C	US-2002/0035487 A1	03-2002	Brummel et al.	705/3
*	D	US-2003/0013951 A1	01-2003	Stefanescu et al.	600/407
*	E	US-2003/0033168 A1	02-2003	Califano et al.	705/3
*	F	US-2003/0208378 A1	11-2003	Thangaraj et al.	705/2
*	G	US-2003/0206646 A1	11-2003	Brackett, Charles C.	382/128
*	H	US-2004/0059597 A1	03-2004	Tkaczyk et al.	705/002
*	I	US-2004/0176986 A1	09-2004	Kuth et al.	705/003
*	J	US-2005/0110788 A1	05-2005	Turner et al.	345/419
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.